

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination PAVLIK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0056012 a1	03-2003	Modeste et al.	709/249
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